First-principles study of In_2S_3 as alternative buffer material for Cu(In,Ga)(Se,S)₂ thin-film solar cells



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Different types of solar cells





CIGS-Modules





Monolithic CIGS on a flexible substrate, installed in Singapore.

Flexible CIGS modules are lightweight and can be incorporated onto vehicle roofs and structures for which heavy PV modules are unsuitable.



efficient stable beautiful flexible

Annual global production of CIGS Modules





Annual global production: CIGS thin film modules

Role of buffer layer





- To form a junction with the absorber layer
- To admit a maximum amount of light to the junction region and absorber layer
- To drive out the photogenerated carries with minimum recombination losses to the outer circuit

In₂S₃ as buffer material



Why substituting CdS buffer layer?

- To avoid toxic metal-containing waste
- To avoid break in the production rate (chemical bath deposition technique)
- To increase QE in blue light region
- To reach higher efficiencies

Why In_xS_v as replacement?

- Enviromentally friendly
- It is compatible with various deposition methods
- Wider band gap when containing O, S or Na



Density Functional Theory (DFT)



P. Hohenberg and W. Kohn, Phys. Rev. B, **136**, B864-B871 (1964).W. Kohn, L.J. Sham, Phys. Rev. **140**, 1133 (1965).



Calculated parameters for β-In₂S₃





	a (Å)	c/a	E _g (eV)	B (GPa)
This work	7.71	4.29	2.13	141
Exp.	7.62 ¹	4.26 ¹	2.1 - 2.4 ^{2,3}	148 ⁴

¹ Rampersadh et al., *Physica B* (2004)

² Sterner et al., *Prog. Photovolt.: Res. Appl.* **13** (2005)

³ Kitaiev et al., Neorg. Mater. 12 (1976)

⁴ Amlouk et al., Jpn. J. Appl. Phys. **38** (1999)

CIGS/In₂S₃ interface: Literature review



Phys. Status Solidi A 206, No. 5, 1059-1062 (2009) / DOI 10.1002/pssa.200881162



Cu in In_2S_3 : interdiffusion phenomena analysed by high kinetic energy X-ray photoelectron spectroscopy

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RESEARCH ARTICLE

Interface engineering and characterization at the atomic-scale of pure and mixed ion layer gas reaction buffer layers in chalcopyrite thin-film solar cells

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Thermodynamic modelling



Defect formation energy	$\Delta H = \Delta H_{D,q} (\boldsymbol{\mu}, \boldsymbol{E}_{\mathbf{F}})$
Defect concentration	$c_{D} pprox \textit{N}_{site} imes \texttt{exp}(-\Delta \textit{H/kT})$
Electron/hole density	$c_{e} = \int f_{FD}(E - E_{F}) g(E) dE$
Charge neutrality	$-c_e + c_h + \Sigma [q \cdot c(D^q)] = 0$
Self-consistent solution	$\Delta H(\boldsymbol{E}_{F}) \longrightarrow c_{D}(\Delta H) \longrightarrow \boldsymbol{E}_{F}$
pO_2 dependence of μ_O	$\Delta \mu_{O}(\boldsymbol{T},\boldsymbol{P}_{0}) = \frac{1}{2} [H_{0} + \Delta H(\boldsymbol{T})] - \frac{1}{2} \boldsymbol{T} \cdot [S_{0} + \Delta S(\boldsymbol{T})]$
(ideal gas)	$\Delta \mu_{O}(T, \mathbf{P}) = \Delta \mu_{O}(T, \mathbf{P}_{0}) + \frac{1}{2} k T \ln(\mathbf{P}/\mathbf{P}_{0})$

High conc.	Account for competition of defects and host atoms for $N_{\rm site}$
	Association/dissociation of <i>defect-clusters</i> (law of mass action)
Direct	Given $\Delta H(\mu)$, find concentrations c_{D}
Inverse	Given a target concentration, find ΔH (i.e., find μ)

Na and Cu in β -In₂S₃





Ghorbani and Albe, J. Mater. Chem. C 6 (2018)

Na and Cu in β -In₂S₃



Is there a driving force for the transfer of Na and Cu into In_2S_3 :

Driving force = $E_{tot}(CIS: V_{Cu}) - E_{tot}(CIS: Na_{Cu}) + E_{tot}(In_2S_3: Na_i) - E_{tot}(In_2S_3: pure)$

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Ghorbani and Albe, J. Mater. Chem. C 6 (2018)

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Ghorbani and Albe, J. Mater. Chem. C 6 (2018)

Absorber/buffer interface





- A moderate spike-like offset (0.0-0.3 eV) suppresses charge recombination.
- A cliff-like offset triggers recombination and reduces the interface band gap.
- Cliff-like conduction band offset must be avoided.

Band alignment between ternary absorber compounds and In₂S₃



Ghorbani, Erhart and Albe, Phys. Rev. Materials 3 (2019)

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Band alignment between ternary absorber compounds and In₂S₃



Ghorbani, Erhart and Albe, Phys. Rev. Materials 3 (2019)

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Oxygen in β -In₂S₃





- β-In₂S₃ is an stable material when subjected to oxygen reservoir.
- For both In- and S-rich samples, formation energies of oxygen in different sulfur sites is low, which indicates that O substituting anionic site forms in indium sulfide in ample concentrations.
- Oxygens in all sulfur sites induce an extremely deep (0/+) donor level close to VBM – Being electrically inactive.

Ghorbani and Albe, Phys. Rev. B 98 (2018)

Chlorine in β -In₂S₃





- β -In₂S₃ is an stable material when subjected to chlorine reservoir.
- Concentration of Cl on sulfur lattice sites is large.
- Incorporation of Cl-on-In sites under In-rich condition are very high in energy, hence, their formation is improbable. However, under S-rich condition their formation becomes probable.
- Incorporation of Cl in all sulfur sites features a raise in n-type conductivity.

Ghorbani and Albe, Phys. Rev. B 98 (2018)

Take-home message



- I. Na and Cu in β -In₂S₃
 - Independent of the CuInSe₂/In₂S₃ interface orientation, having a stable interface in the presence of Na and Cu reservoir is thermodynamically impossible
- **II.** Band alignemnt at the absorber/buffer interface
 - In₂S₃ forms an unfavorable cliff-like CBO with all CIGS absorber compounds
 - At the Culn₅Se₈/Culn₅S₈ interface, the CBO has a spike of 0.03 eV
 - At the Culn₅Se₈/Naln₅S₈ interface, the CBO has a spike of 0.12 eV
- III. O and Cl in β -In₂S₃
 - Despite Cu and Na, O and Cl in the buffer side of the interface present in lower concentrations, and do not trigger chemical modification of the In₂S₃
 - O_i and Cl_{In} are the sources of n-type PPC in doped In₂S₃
 - There is a large miscibility gap between In₂S₃ and In₂O₃

